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July 2015

### FDMC2514SDC

# N-Channel Dual Cool<sup>TM</sup> 33 PowerTrench<sup>®</sup> SyncFET<sup>TM</sup> 25 V, 40 A, 3.5 m $\Omega$

#### Features

- Dual Cool<sup>TM</sup> Top Side Cooling PQFN package
- Max  $r_{DS(on)}$  = 3.5 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 22.5 A
- Max r<sub>DS(on)</sub> = 4.7 mΩ at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 18 A
- High performance technology for extremely low r<sub>DS(on)</sub>
- SyncFET Schottky Body Diode
- RoHS Compliant

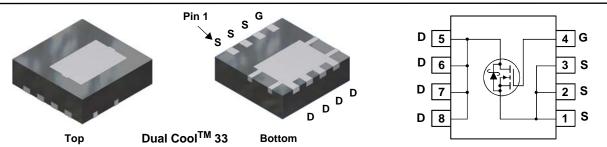


#### **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process. Advancements in both silicon and Dual Cool<sup>TM</sup> package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance. This device has the added benefit of an efficient monolithic Schottky body diode.

#### Applications

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation Vcore Low Side



**MOSFET Maximum Ratings**  $T_A = 25^{\circ}C$  unless otherwise noted

Symbol	Parameter			Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage			25	V
V <sub>GS</sub>	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C		40	
	-Continuous (Silicon limited)	T <sub>C</sub> = 25 °C		106	•
D	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	24	A
	-Pulsed			200	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	84	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 5)	2.0	V/ns
D	Power Dissipation T <sub>C</sub> = 2			60	w
PD	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	3.0	VV
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	5.8	
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	2.1	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	105	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	17	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	12	

#### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity	
2514S	FDMC2514SDC	Dual Cool <sup>TM</sup> 33	13"	12 mm	3000 units	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Chara	octeristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	25			V	
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 10 mA, referenced to 25 °C		21		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			500	μΑ	
I <sub>GSS</sub>	Gate to Source Leakage Current, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA	
On Chara	cteristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$	1.2	1.7	3.0	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_{.1}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 10 \text{ mA}$ , referenced to 25 °C		-5		mV/°C	
0	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 22.5 A		2.5	3.5		
r <sub>DS(on)</sub>		$V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$		3.6	4.7	mΩ	
DO(OII)		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 22.5 A, T <sub>J</sub> = 125 °C		3.5	4.5	1	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 22.5 \text{ A}$		122		S	
C <sub>oss</sub> C <sub>rss</sub> Rg	Output Capacitance Reverse Transfer Capacitance Gate Resistance	f = 1 MHz		596 134 1.1	795 205	pF pF	
'`g					24	0	
Switching					2.4	Ω	
	g Characteristics						
t <sub>d(on)</sub>		Vop = 13 V lp = 22 5 A		11 3.6	2.4 22 10	Ω ns ns	
t <sub>d(on)</sub> t <sub>r</sub>	g Characteristics Turn-On Delay Time	$V_{DD}$ = 13 V, I <sub>D</sub> = 22.5 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω		11	22	ns	
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub>	<b>g Characteristics</b> Turn-On Delay Time Rise Time			11 3.6	22 10	ns ns	
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		11 3.6 26	22 10 41	ns ns ns	
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub>	<b>g Characteristics</b> Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V} \text{ to } 10 \text{ V}$		11 3.6 26 3	22 10 41 10	ns ns ns ns	
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub>	y Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		11 3.6 26 3 31	22 10 41 10 44	ns ns ns ns nC	
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>gs</sub>	y Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 13 \text{ V},$		11 3.6 26 3 31 14	22 10 41 10 44	ns ns ns ns nC nC	
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	y Characteristics Tum-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Gate Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 13 \text{ V},$		11 3.6 26 3 31 14 6.5	22 10 41 10 44	ns ns ns nC nC nC	
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> <b>Drain-So</b> t	y Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Gate Charge Gate to Drain "Miller" Charge urce Diode Characteristics	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 13 \text{ V},$ $I_{D} = 22.5 \text{ A}$		11 3.6 26 3 31 14 6.5	22 10 41 10 44	ns ns ns nC nC nC	
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	y Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Gate Charge Gate to Drain "Miller" Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 13 \text{ V},$		11 3.6 26 3 31 14 6.5 3.9	22 10 41 10 44 20	ns ns ns nC nC nC	
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> <b>Drain-So</b> t	y Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Gate Charge Gate to Drain "Miller" Charge urce Diode Characteristics	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 13 \text{ V},$ $I_{D} = 22.5 \text{ A}$ $V_{GS} = 0 \text{ V}, \text{ I}_{S} = 22.5 \text{ A}$ (Note 2)		11 3.6 26 3 31 14 6.5 3.9 0.79	22 10 41 10 44 20	ns ns ns nC nC nC nC	

FDMC2514SDC N-Channel Dual Cool<sup>TM</sup> 33 PowerTrench<sup>®</sup> SyncFET<sup>TM</sup>

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	5.8	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	2.1	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	105	
R <sub>θJA</sub>	Thermal Resistance, Junction to Ambient	(Note 1c)	29	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	40	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	19	°C 444
R <sub>0JA</sub>	Thermal Resistance, Junction to Ambient	(Note 1f)	23	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	30	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	79	
R <sub>θJA</sub>	Thermal Resistance, Junction to Ambient	(Note 1i)	17	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	26	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	12	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	16	

NOTES:

1. R<sub>0JA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 42 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 105 °C/W when mounted on a minimum pad of 2 oz copper

c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
 d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

g. 200FPM Airflow, No Heat Sink,1 in<sup>2</sup> pad of 2 oz copper

h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper

i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

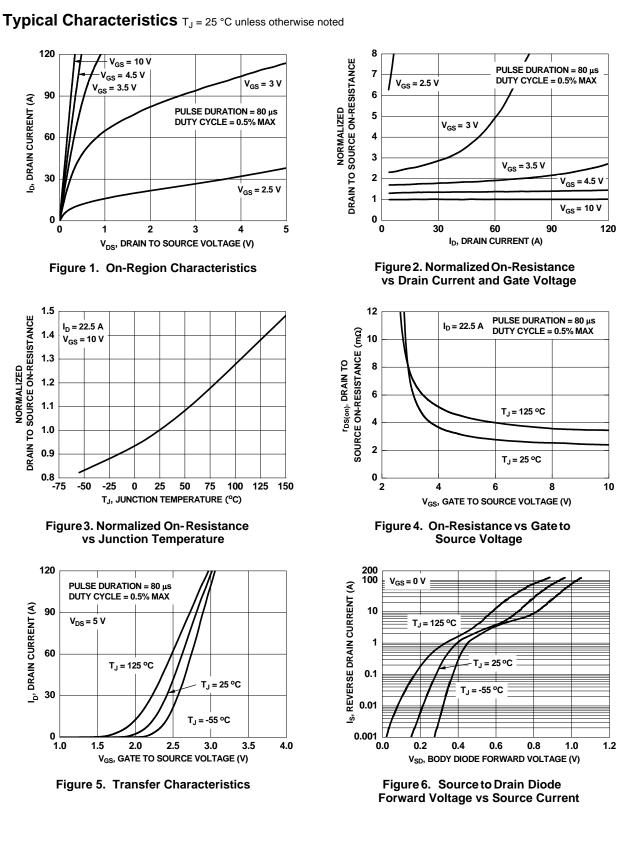
2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty cycle < 2.0%.

3. E<sub>AS</sub> of 84 mJ is based on starting T<sub>J</sub> = 25 °C, L = 1 mH, I<sub>AS</sub> = 13 A, V<sub>DD</sub> = 23 V, V<sub>GS</sub> = 10 V. 100% test at L = 0.3 mH, I<sub>AS</sub> = 20 A.

4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.

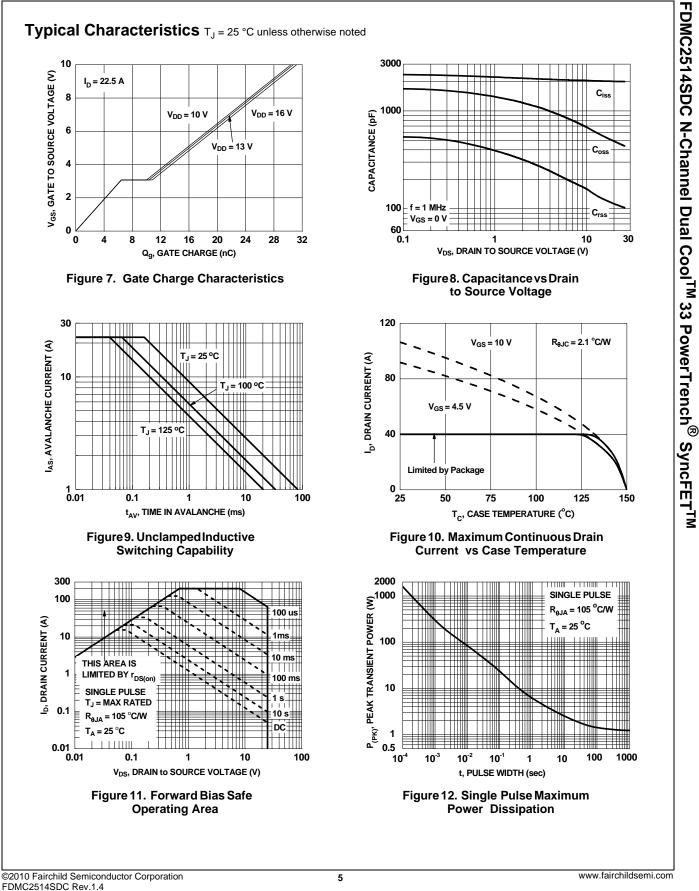
5.  $I_{SD} \leq$  22.5 A, di/dt  $\leq$  200 A/µs,  $V_{DD} \leq$   $BV_{DSS},$  Starting  $T_J$  = 25  $^oC.$ 

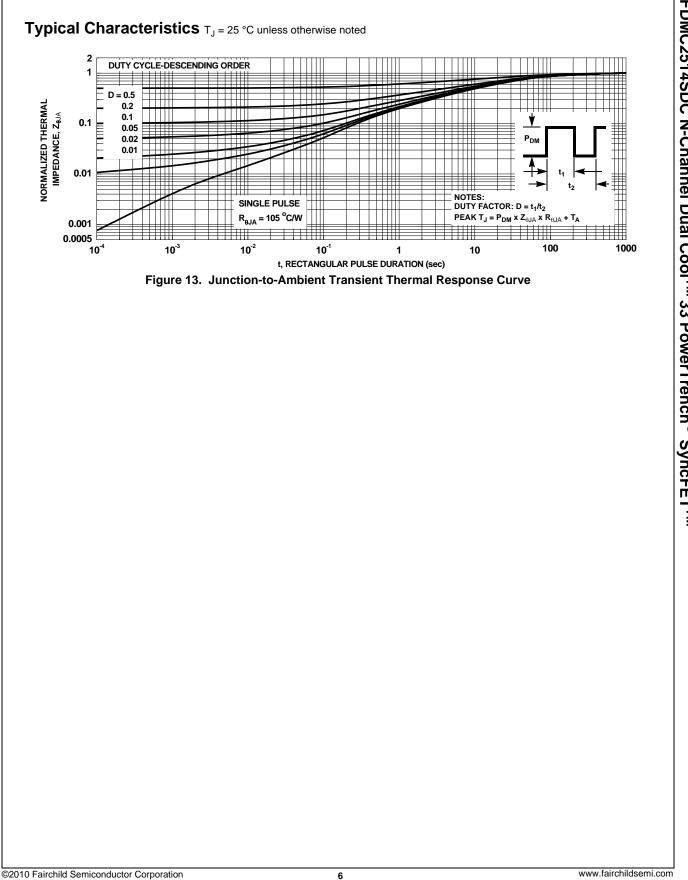
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FDMC2514SDC Rev.1.4

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#### Typical Characteristics (continued)

#### SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 13 shows the reverse recovery characteristic of the FDMC2514SDC.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

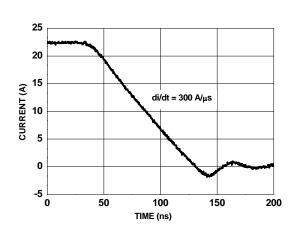


Figure 13. FDMC2514SDC SyncFET body diode reverse recovery characteristic

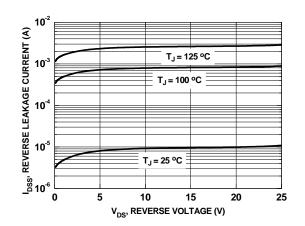
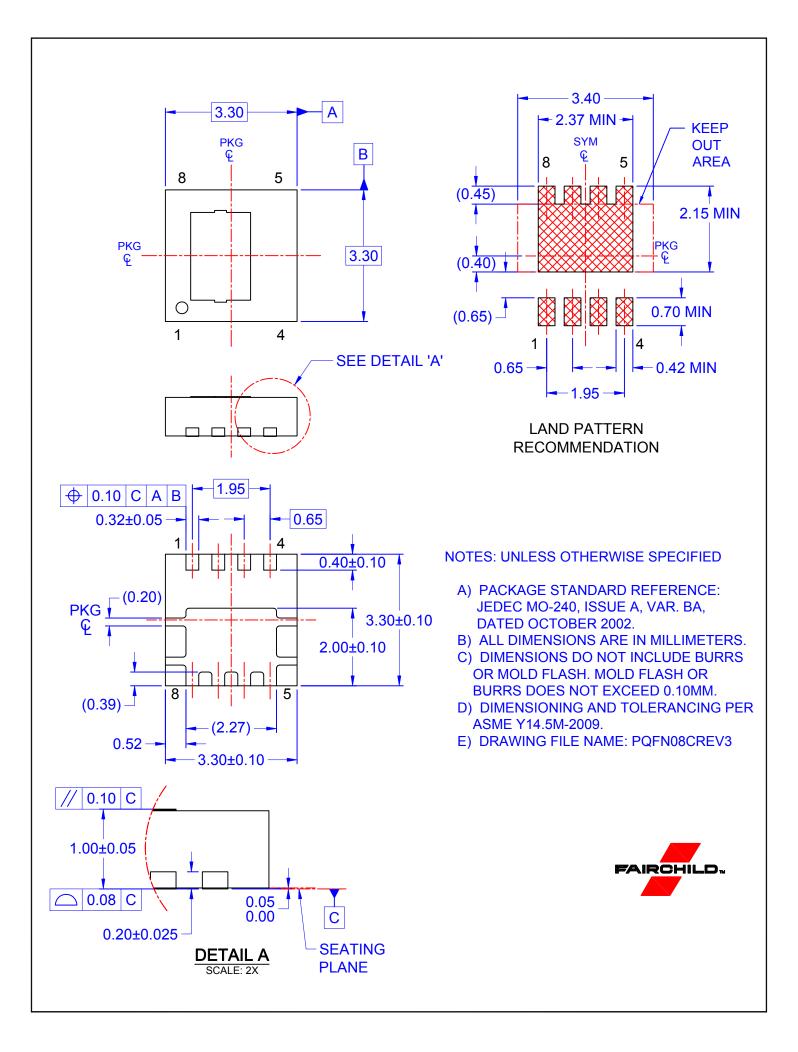


Figure 14. SyncFET body diode reverse leakage versus drain-source voltage



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